Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/519,006	SPECHT ET AL.	
Examiner -	Art Unit	
Lois Zheng	1793	

SEARCHED						
Subclass	Date	Examiner				
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	Subclass	Subclass Date				

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Inventorship search	11/13/2007	LLZ		
EAST Search	11/13/2007	LLZ		
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